Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | ABBOTT ET AL. | Examiner | Art Unit | Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,054,824	05-2006	Grenchus et al.	705/7
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-		·	
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р			·		•
	Q					
	R					
	S				·	
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Louis, Brennan et al., Operations planning issues in an assembly/disassembly environment International Journal of Operations & Production, Vol. 1,4 No. 9, 1994
	V	Taleb, Karim Nazih, Operational issues in disassembly Northeastern University, 1995, AAT 9532566, Abstract
	w	Goan, Meng-Jong, An integrated approach to environmentally-conscious design and manufacturing Virginia Polytechnic Institute and State University, AAT 9638608, Abstract, 1996
	x	Jayaraman V. et al., A closed-loop logistics model for remanufacturing Journal of the Operational Research Society, Vol. 50, 1999, Pages 497-508

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 09/808,067 Examiner Scott L. Jarrett Applicant(s)/Patent Under Reexamination ABBOTT ET AL. Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	C	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-		•	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q.					
	R					
	s	•			·	•
	Т					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	υ	2000 IEEE International Symposium on Electronics and the Environment - Agenda, 2000
	V	Dietrich, Brenda et al., Big Benefits for Big Blue OR/MS Today, June 2000
	w	Veerakamolmal, P. and Gupta, S., Optimizing the Supply Chain in Reverse Logistics 2000 IEEE International Symposium on Electronics and the Environment
	· x	Gupta, Surendra and Verrakamolmal, P., A Bi-directional Supply Chain Optimization Model for Reverse Logistics 2000 IEEE International Symposium on Electronics and the Environment

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. O9/808,067 Examiner Scott L. Jarrett Applicatios/Patent Under Reexamination ABBOTT ET AL. Art Unit Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*	,	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N			<u>.</u>		
	0					
	Р					
	α		·			
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
•	, U ^	Kasmara, Andre et al., Production planning in remanufacturing/manufacturing production system IEEE, 2001
	٧	Veerakamolmal, Pitipong, Design and Analysis of Disassembly and Remanufacturing Systems in the Electronics Industry Doctorial Thesis, Northeastern University, UMI 9937438, June 1999
-	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.